

**Notice of References Cited**Application/Control No.  
**09/476,241**Applicant(s)/Patent Under Reexam  
**Takahiro Kimoto**Examiner  
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**2613**

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**U.S. PATENT DOCUMENTS**

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification</b> <sup>2</sup>	
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B	4,651,206	3/1987	Ohki	375	240.16
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**NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages				
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<sup>1</sup> Dates in MM-YYYY format are publication dates.<sup>2</sup> Classifications may be U.S. or foreign.